

Quarterly Reliability Monitoring Results

Quarters: Q1/2022 to Q4/2023

Based on structural similarity

Nexperia B.V.		User Part Number						
Nexperia B.V. Name of Laboratory Assembly reliability labs Based on AEC-Q101 Test		BC857AQC-Q						
		Part Description						
		Nexperia DHAM Small Signal Bipolar Transistor						
		MCD package						
		Test Conditions	Duration	# Lots	# Quantity	# Rejects		
1	TEST							
F	Pre- and Post-Stress							
# E1 E	Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below		
-	PC Preconditioning	JESD22-A113 Bake Tamb = 125 °C Soak Tamb = 85 °C, RH = 85% Reflow soldering	24 hours 168 hours 3 cycles	464	20960	0		
# A1		MIL-STD-750-1	,	707	20300	0		
F	HTRB High Temperature Reverse Bias	M1039 Method A Tj = Tjmax, Vr = 100% of max. datasheet reverse voltage	1000 hours	415	18680	0		
-	FC Femperature Cycling	JESD22-A104 -65 °C to Tjmax, not to exceed 150°C	1000 cycles	116	5240	0		
	JHAST Jnbiased HAST	JESD22-A118 Tamb = 130 °C, RH = 85 %	— 96 hours	116	5240	0		
-	AC Autoclave	JESD22-A102 Tamb = 121 °C, RH = 100 % Pressure = 205 kPa (29.7 psia)						
H	H3TRB High Humidity High Femperature Reverse Bias	JESD22-A101 Tamb = 85 °C, RH = 85%, VR = 80 % of rated reverse voltage $^{[1]}$	1000 hours	116	5240	0		
_	OL Intermittent Operating Life	MIL-STD-750 Method 1037 ton = toff, devices powered to insure $\Delta Tj = 100$ °C for 15000 cycles	1000 hours	116	5240	0		
F	RSH	JESD22-A111						
<i>"</i> CO	Resistance to Solder Heat	260 °C ± 5 °C	10 s	n.a.	n.a.	n.a.		
_	SD Solderability	J-STD-002		86	2580	0		

^[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test #B1) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

Wafer Fab	Technology	Quantity	Rejects	Failure Rate (FIT)	MTTF (hrs)
Nexperia	Small Signal Bipolar				
DHAM	Transistor	18680	0	0,23	4,40E+09

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